

Notice of References Cited	Application/Control No. 10/720,475	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner Raeann Gorden	Art Unit 3711	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0114246 A1	06-2003	Yokota, Masatoshi	473/351
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NON-PATENT DOCUMENTS

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